

Notice of References Cited	Application/Control No. 10/568,449		Applicant(s)/Patent Under Reexamination AYEL ET AL.	
	Examiner JASON M. MANDEVILLE		Art Unit 2629	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,072,454	06-2000	Nakai et al.	345/97
*	C	US-7,173,593	02-2007	Matsumura et al.	345/98
*	D	US-6,466,194	10-2002	Atherton, James Harold	345/100
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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